 arch Notes

 Application/Control No.	Applicant(s)/Patent under Reexamination	
09/868,749	VAN DEN HOVEN ET AL.	
Examiner	Art Unit	
Kieu D. Vu	2173	

	SEARCHED		
Class	Subclass	Date	Examiner
715	723	7/31/2006	кv
715	730	7/31/2006	ΚV
	<u>.</u>		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
	,			
USPAT-L	JSPGPUB	8/1/2006	KV	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East search (USPAT USPGPUB EPO JPO DERWENT IBM_TDB USOCR) (See Search History Printout)	7/31/2006	κv
715/731 715/732 715/835 715/838 715/810 715/769	7/31/2006	ΚV
715/770 715/716 715/719 715/784 715/786	7/31/2006	ΚV
http://www.google.com	8/1/2006	KV
IEEE Xplore	8/1/2006	ΚV
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